



OP07S and OP77S Aerospace Models Change in Wafer Diameter

OP07S and OP77S

OP07S AND OP77S QUALIFICATION PLAN/RESULTS

TEST NAME	CONDITION	MATERIAL ID	STATUS
High Temp Operating Life Test	MIL-STD-883, TM1005 TA = +125C, 1000 Hrs.	Wafer Lot 772201.1	Est. Completion Date 08/05/2025
Total Ionizing Dose (Radiation Hardness)	MIL-STD-883, TM1019 Condition A	Wafer Lot 772201.1 Slice 4	Complete, All Passed HDR-25-0037